# TOSHIBA

## MICROWAVE POWER GaAs FET TIM1213-10L

MICROWAVE SEMICONDUCTOR TECHNICAL DATA

#### **FEATURES**

- ·BROAD BAND INTERNALLY MATCHED FET ·HIGH POWER
- P1dB= 40.5dBm at 12.7GHz to 13.2GHz

### •HIGH GAIN G1dB= 6.0dB at 12.7GHz to 13.2GHz

#### • LOW INTERMODULATION DISTORTION IM3= -45dBc at Pout= 29.0dBm Single Carrier Level

**·HERMETICALLY SEALED PACKAGE** 



### **RF PERFORMANCE SPECIFICATIONS** (Ta= $25^{\circ}$ C)

CHARACTERISTICS	SYMBOL	CONDITIONS	UNIT	MIN.	TYP.	MAX.
Output Power at 1dB Gain Compression Point	P1dB	VDS= 9V IDSset= 4.0A f = 12.7 to 13.2GHz	dBm	40.0	40.5	_
Power Gain at 1dB Gain Compression Point	G1dB		dB	5.0	6.0	
Drain Current	IDS1		А		4.0	5.0
Gain Flatness	ΔG		dB			±0.8
Power Added Efficiency	ηadd		%		23	
3rd Order Intermodulation Distortion	IM3	Two Tone Test Po= 29.0dBm, ∆f= 5MHz (Single Carrier Level)	dBc	-42	-45	
Drain Current	IDS2		А		4.0	5.0
Channel Temperature Rise	∆Tch	(VDS X IDS + Pin – P1dB) X Rth(c-c)	°C			90

Recommended Gate Resistance(Rg): 100  $\Omega$ 

### ELECTRICAL CHARACTERISTICS (Ta= 25°C)

CHARACTERISTICS	SYMBOL	CONDITIONS	UNIT	MIN.	TYP.	MAX.
Transconductance	gm	VDS= 3V IDS= 4.8A	S	_	3.0	_
Pinch-off Voltage	VGSoff	VDS= 3V IDS= 145mA	V	-1.5	-3.5	-5.0
Saturated Drain Current	IDSS	VDS= 3V VGS= 0V	A	_	10.0	
Gate-Source Breakdown Voltage	VGSO	IGS= -145 <sub>µ</sub> A	V	-5		
Thermal Resistance	Rth(c-c)	Channel to Case	°C/W		2.0	2.5

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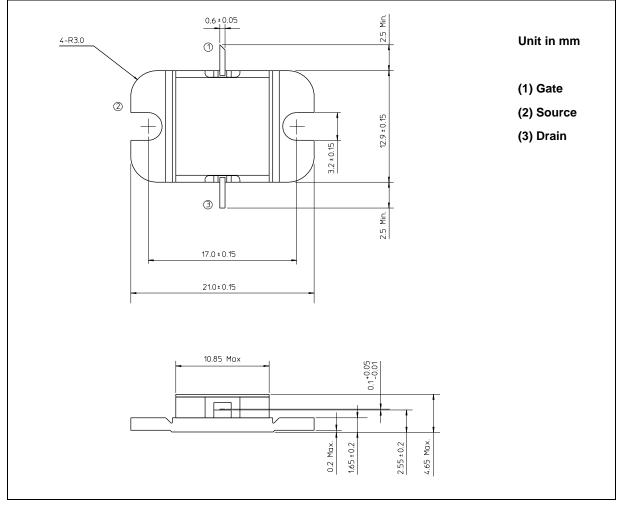
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### ABSOLUTE MAXIMUM RATINGS (Ta= 25°C)

CHARACTERISTICS	SYMBOL	UNIT	RATING
Drain-Source Voltage	VDS	V	15
Gate-Source Voltage	VGS	V	-5
Drain Current	IDS	A	11.5
Total Power Dissipation (Tc= 25°C)	PT	W	60
Channel Temperature	Tch	°C	175
Storage	Tstg	°C	-65 to +175

### PACKAGE OUTLINE (2-11C1B)



### HANDLING PRECAUTIONS FOR PACKAGE MODEL

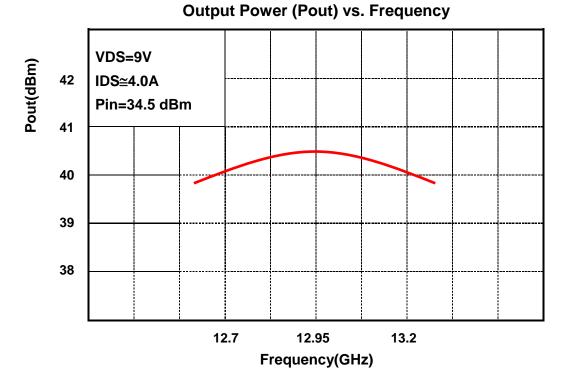
Soldering iron should be grounded and the operating time should not exceed 10 seconds at 260°C or 3 seconds at 350°C.

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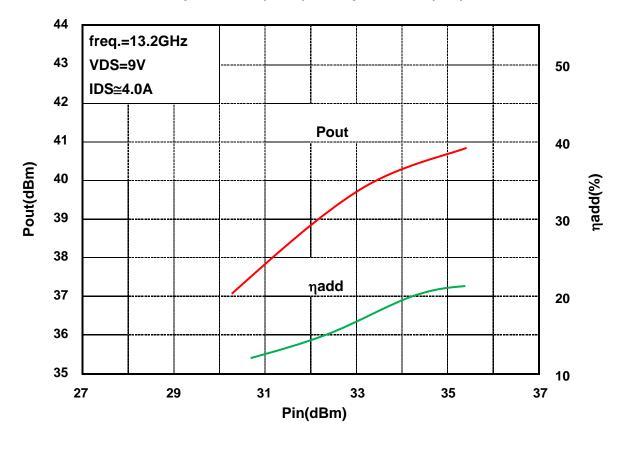
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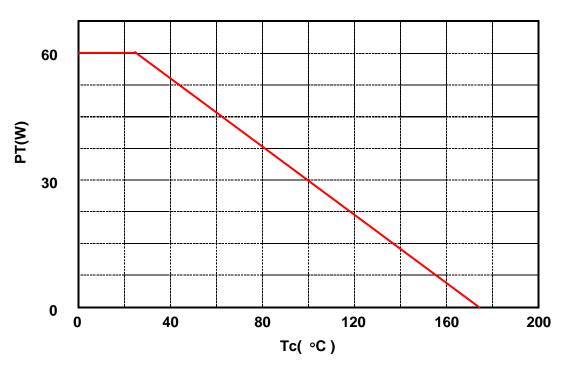
### **RF PERFORMANCE**



Output Power(Pout) vs. Input Power(Pin)



MICROWAVE SEMICONDUCTOR TECHNICAL DATA



### Power Dissipation(PT) vs. Case Temperature(Tc)



